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The Growth of Silicon Sheets for Photovoltaic Applications

Thomas Surek

SERI

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A Division of Midwest Research Institute

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THE GROWTH OF SILICON SHEETS
FOR PHOTOVOLTAIC APPLICATIONS

THOMAS SUREK

DECEMBER 1980

PREPARED UNDER TASK NO. 3821.02

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PREFACE

This report is based on an invited presentation by the author in the Symposium on "Novel Silicon Growth Methods" at the 157th meeting of The Electrochemical Society held in St. Louis, Missouri, on 11-16 May 1980. Proceedings of the symposium are to be published by The Electrochemical Society. The report presents a critical assessment of the various silicon sheet growth processes under development for low-cost terrestrial photovoltaics.

Thomas Surek

Approved for

SOLAR ENERGY RESEARCH INSTITUTE

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SUMMARY

Objective: Review and compare four "fast" ribbon, silicon sheet growth processes—dendritic-web growth (WEB), edge-defined film-fed growth (EFG), ribbon-to-ribbon growth (RTR), and the silicon-on-ceramic process (SOC)—and identify some of the problems that need to be resolved.

Discussion: The potential to meet the low-cost objectives for terrestrial photovoltaics of a number of silicon sheet growth processes is nearly ready to be demonstrated. Silicon sheet growth processes are classified according to their linear growth rates. The "fast" growth processes are comparatively ranked subject to criteria involving growth stability, sheet productivity, impurity effects, crystallinity, and solar cell results. The status of more rapid silicon ribbon growth techniques, such as horizontal ribbon growth and melt quenching, is also reviewed. The emphasis of the discussion is on examining the viability of these sheet materials as solar cell substrates for low-cost silicon photovoltaic systems.

Conclusions: Although there is good reason to expect that the objectives to achieve low-cost silicon photovoltaic systems will be met, it is not possible to choose, in the author's opinion, among the various sheet growth processes at this time. This is especially true if one considers the results of the more rapid sheet growth techniques also reviewed in this paper, or the results of other novel sheet growth approaches reported recently.

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SECTION 1.0

INTRODUCTION

A variety of novel silicon crystal growth methods have evolved over the past few years in attempts to reduce the cost of silicon photovoltaic systems. Techniques to grow silicon sheets directly are especially attractive in that the slicing costs and material losses of conventional techniques are eliminated. This paper reviews the status of these novel growth methods and examines the advantages and limitations of the techniques from the points of view of growth stability, the potential to use low-cost silicon starting materials, the crystalline and photovoltaic quality of the silicon sheet, and the overall low-cost potential of the techniques.

Silicon solar cell substrates have been obtained directly from the melt in the form of both unsupported and supported sheets. The growth of sheet crystals from the melt relies on some form of control of the crystallization front through control of the temperature distributions in the crystal growth system, and, in some cases, through control of the liquid-vapor interface (or meniscus) shape. Precise control of the temperature distribution in the melt permits the crystallization of dendrites which support the thin, solidifying web in web-dendrite growth (denoted by WEB in this report). The use of a capillary die to control the shape of the meniscus reduces to some extent the thermal control requirements of edge-defined film-fed growth (EFG). In the ribbon-to-ribbon (RTR) process, a form of meniscus shape control is inherent; the ribbon on the feed side takes the place of the EFG die. In the rigid-edge RTR process, the stability is further enhanced because the sharp meniscus curvatures at the ribbon edges are eliminated. Horizontal ribbon growth techniques require precise control of the temperature distribution in the melt and of the cooling of the solidifying ribbon surface. In supported-sheet techniques, the thermal control requirements are alleviated by the stabilizing effects of the supporting substrate on the meniscus shape. Silicon sheets have been grown on supporting substrates such as mullite by the silicon-on-ceramic (SOC) process and graphite by the ribbon-against-drop (RAD) process. Further discussion of the growth stability in these sheet growth processes is presented in later sections; detailed descriptions of the techniques can be found in the literature (Cullen and Surek 1980).

A characteristic of all sheet growth techniques is that the linear growth rates are much greater than the crystal growth rates in the conventional ingot growth techniques. A classification of sheet growth processes may be made on the basis of these linear rates, as shown in Fig. 1. The rapid growth rates result from the manner in which the latent heat of solidification is removed from the solid-liquid interface. In the "fast" growth techniques, the growth interface is essentially perpendicular to the crystal pulling direction; the high surface-to-volume ratio of the thin sheet crystal permits the effective removal of the latent heat, by radiative and convective processes, from the sheet surface (see schematic in Fig. 1). "Faster" growth rates can be obtained in horizontal ribbon growth processes, in which the solid-liquid interface is nearly parallel to the crystal pulling direction. In the "fastest" ribbon growth techniques, the latent heat is removed very effectively by conduction to a rapidly rotating, cooled wheel.

The major part of this paper is concerned with the "fast" ribbon growth techniques which have received the most attention over the past few years and thus are considerably more advanced than the relatively novel horizontal ribbon growth or melt quenching techniques. Section 2.0 presents a comparison and a qualitative ranking of four of the processes (EFG, WEB, SOC, RTR) listed in Fig. 1; many of the conclusions reached about the SOC process should apply to the RAD process as well. Recent advances in silicon

"Fast" Ribbon Growth	1-10 cm/min		EFG, WEB SOC, RTR RAD
"Faster" Ribbon Growth	10-100 cm/min		Horizontal Ribbon Growth
"Fastest" Ribbon Growth	$\gg 100$ cm/min		Melt Quenching or Spinning

Figure 1. Classification of Silicon Sheet Growth Processes According to Linear Growth Rate.

Schematics show crystal pulling direction (straight arrows) and heat loss directions (wavy arrows).

sheets grown by the RAD process are described in the literature (Electrochemical Society 1980). The status of the "faster" and "fastest" ribbon growth techniques is reviewed in Section 3.0.

SECTION 2.0

COMPARISON OF "FAST" RIBBON GROWTH TECHNIQUES

The criteria used to compare the "fast" ribbon growth techniques are: (1) stability, (2) productivity, (3) impurity effects, (4) crystallinity, and (5) solar cell results. Included in each of these major criteria are several subcriteria as described below. Most of the information presented here is based on that available in the published literature; additional data was obtained from various reports from U. S. Government-sponsored research. The author has also contacted each of the organizations pursuing the research to obtain up-to-date information on their processes, as well as their comments concerning the criteria used in the comparisons.

It should be noted that the criteria used in this paper are those of the author, and do not necessarily include all the criteria needed to judge these processes. The chosen criteria, however, emphasize the technical advantages and limitations of the various techniques, as well as help to identify some of the major problem areas that need to be resolved to attain the low-cost objectives for terrestrial photovoltaics. The "rankings" which are presented are also those of the author; in many cases, they are based on subjective and somewhat speculative considerations and may be disputed by the reader.

	Thermal Control	Meniscus Control	Interface Shape	Thickness/ Width Control	Continuous Growth	Concerns
SOC	Dip-coat understood; * Active preheater; Passive control of temp. profile; $\pm 5-10^{\circ}\text{C}$ in trough	Some understanding of SCIM; Growth stable at $15-20^{\circ}$ angle; Some edge effects	Lateral very important; Asymmetric growth possible	$t = f(\text{velocity})$ * $50 - 200\ \mu\text{m}$; $w = f(\text{substrate})$ Good control	Batch; No automation; Manual melt level control	Substrate cost; Temp. uniformity; Mech. design; Nonwetting; Automation
RTR	T_{solid} understood; Active pre/afterheater; Manual laser power control; Self stabilization	Rigid edges stabilize growth; Melt shape/size to be controlled	Controlled with laser scan and power input (w, t)	$t = f(\text{feedstock})$ $\pm 50\ \mu\text{m}$; $w = f(w_{\text{scan}})$ $\pm 1\ \text{mm}$	Batch, some semicontinuous; Visual control of melt shape	Cost of laser (Use e-beam?); Automation; Feedstock; Stresses
EFG	Theory developed; Active die (edge/ face) heaters and afterheater; $\pm \text{few } ^{\circ}\text{C}$ in crucible	Theory developed; Meniscus height and edge position controls; Bulbous dies stabilize edges	Controlled with die design and thermal elements (w, t)	$t = f(\text{die}, \dots)$ $\pm 50\ \mu\text{m}$; $w = f(\text{die})$ $\pm 50\ \mu\text{m}$	Yes; Automation developed; Melt replenish	Freezes; Automated growth initiation; Stresses
WEB	Theory developed; Passive control of temp. profile; $\pm \text{few tenths } ^{\circ}\text{C}$ in crucible	Studies based on heat flow; Lateral profile very important; Shaped radiation shields provide passive control		$t = f(\text{velocity})$ $\pm \text{few } \mu\text{m}$; $w = f(T_{\text{width}})$ Need melt level control	Some; Melt level control with replenishment	Pullouts; Automation (w, melt level); Temp. control; Stresses

Figure 2. Comparison of "Fast" Sheet Growth Processes According to Growth Stability

The ranking (top to bottom) is based on the best ultimate potential. The asterisk (*) denotes best potential in a given area.

2.1 STABILITY

One of the most important criteria for comparing sheet growth techniques is the stability of the growth process. Figure 2 lists the various subcriteria used for this comparison; the techniques are listed in order of the best ultimate potential, in the author's estimate. Areas where a given technique appears to have some advantages over the others are also indicated in the figure. The following discussion focuses on the most important points in the figure; the other entries should be self-explanatory.

The SOC process is likely to have the least sensitive thermal control requirements; researchers estimate that a 5° to 10°C variation in temperature along the trough (i.e., the width of the sheet) should be tolerable. (In this discussion of the SOC process, it should be noted that the silicon coating by inverted meniscus or SCIM-coating technique, where a carbon-coated mullite substrate is passed over a trough containing molten silicon, is being considered.) Meniscus stability is obtained if the coating is carried out at an angle with respect to the horizontal of 15 to 20 degrees. In spite of the laxity of thermal control requirements, control of the lateral interface shape is one of the major current concerns in the process. Interface shape control in the thickness dimension (i.e., asymmetric growth) may be required to achieve the high throughput rates for low cost. The thickness and width control data listed in Fig. 2 represent the state of the art; the SOC technique probably offers the best overall potential in this area.

In the RTR process, the temperature profile in the solid is actively controlled by pre- and after-heaters, but the power input to the laser is controlled manually, based on visual observation. In terms of meniscus shape control at the ribbon edges, the rigid-edge RTR offers the most advantages; the stability will be further enhanced if automatic controls for the melt shape and size are developed. Appropriate control of the laser scan may also lead to control of the interface shape in the width and thickness dimensions.

The EFG technique probably has the best-developed theories of thermal and meniscus controls. Theoretical considerations have resulted in automated controls of the temperature profile in the ribbon and of the meniscus height and ribbon edge positions. EFG also offers the best potential for direct control of the shape of the growth interface through appropriate designs of the die and of the active die-heater elements.

In the WEB technique, theoretical attention has focused on the temperature profiles in the melt and in the web crystal. These are passively controlled by the design of the radiation shields. Achievement and maintenance of the proper lateral temperature distribution in the melt is one of the major concerns to be resolved in this technique. Control of the melt level in the crucible, with continuous melt replenishment, should significantly alleviate the growth control problems.

Additional data are presented in Fig. 2 on the state of the art of thickness and width control and of the approaches to continuous growth. In the SOC and RTR techniques, the aim is to achieve semicontinuous growth (i.e., finite sheet lengths). Finally, some of the major concerns for the various techniques are listed. A common concern for all the processes is the achievement of a high yield of suitable solar cell substrate materials at the high productivity rates required for low cost.

2.2 PRODUCTIVITY

The ranking of sheet growth processes according to productivity criteria is shown in Fig. 3; this ranking is based on the current status of the technologies. The two sets of figures in the first three columns represent the best values achieved (on top) and the values routinely obtained (on bottom) for the respective parameters. Many of the "best" values listed have been exceeded under non-steady-state growth conditions.

The fastest linear growth rates have been achieved with the SOC technique, while the widest sheets are consistently grown by EFG, where 5- or 10-cm-wide ribbons are grown routinely depending on the width of the die. The thinnest sheet is obtained most consistently by the WEB technique. Thinner coatings could be achieved by SOC, but very likely at the expense of sheet quality for photovoltaic applications. In terms of continuous and multiple growth, as well as automation, EFG is the current leader among the sheet technologies. Multiple growth (i.e., simultaneous growth from the same crucible) of 5- and 10-cm-wide ribbons has been achieved, as indicated in Fig. 3. Automation is based on meniscus height and ribbon edge position controls. No appreciable deterioration of the graphite die was reported after the 15-hour growth experiment. Initial efforts at melt replenishment in the WEB technique have permitted growth over a 17-hour period, resulting in ribbon lengths of 3 to 4 m; in addition, two web crystals (in separate furnaces) were grown under the control of a single operator. Multiple growth has also been demonstrated in the RTR process.

The right-hand column in Fig. 3 lists the productivity goals for the various techniques. Simultaneous achievement of these goals is necessary to meet the low-cost silicon sheet objectives for terrestrial photovoltaics (i.e., a module price of \$0.70/W_p). The

parameters listed represent (top-to-bottom): linear or area growth rate, sheet thickness, multiple growth requirements, and length of the growth cycle. The RTR process is envisioned to become semicontinuous, involving finite ribbon segments in a cassette-based operation. High yields of usable sheet material ($\geq 90\%$, depending on the process) are also required to meet the low-cost goals.

2.3 IMPURITY EFFECTS

The following aspects of impurity effects are considered in the process ranking: the potential sources of impurities, the possibilities to segregate and/or redistribute impurities during the growth process, and the potential to use a low-grade silicon feedstock in the process without detrimental effects on the growth. The ranking of the processes, based on the ultimate potentials of the techniques, is shown in Fig. 4.

In addition to the specific sources of impurities cited in Fig. 4, common sources of impurities for all the processes are the silicon feedstock and the furnace environment in which the growth is carried out. The WEB process, because it most closely approximates the conventional silicon growth methods, has the best potential from the point of view of impurity sources. The WEB process also permits the rejection of segregated impurities; in short growth runs, effective segregation coefficients (k_{eff}) somewhat higher than the equilibrium value have been found. Theoretical calculations predict that $k_{eff} \leq 1$ in long-term growth runs with continuous melt replenishment. Some purification should also be possible in the RTR process, at least over the initial portions of the recrystallized ribbon.

The redistribution of impurities can be controlled very effectively in the EFG process by appropriate designs of the capillary channels in the die; control of impurity redistribution has been demonstrated in both the width and thickness dimensions of the ribbon. The RTR and SOC techniques also offer, in principle, the potential for controlling the distribution of impurities through appropriate control of the shape of the growth interface.

Finally, in several of the techniques listed in Fig. 4, there has been some growth experience using an impure silicon feedstock, such as metallurgical-grade (mg) silicon. Qualitatively, it is expected that the effect on growth stability (e.g., constitutional supercooling) will decrease from WEB to SOC in the order indicated in the figure. The ultimate concern in using a low-grade silicon feedstock is the quality of the silicon sheet for photovoltaic applications. In this regard, it should be noted that only the WEB process results in some degree of purification ($k_{eff} < 1$).

2.4 CRYSTALLINITY

In a comparison based on crystallinity criteria, it is clear that the WEB process has the best potential. It is the only sheet growth process which yields an essentially single-crystal substrate with a mirror-like surface. The other techniques, as indicated in Fig. 5, yield essentially similar structures consisting mainly of twin boundaries parallel to the growth direction, and other defects. There is some possibility in these techniques for controlling the crystalline structure with appropriate control of the solid-liquid interface shapes in the thickness and width dimensions. Such control has been demonstrated in both the EFG and RTR processes. In addition, control of furnace environment has been shown to affect the crystallinity of EFG ribbons, as discussed by Kalejs et al. (Electrochemical Society 1980). A major concern in all the unsupported sheet growth

	Rate (cm/min)	Width (cm)	Thickness (μm)	Continuous Growth	Multiple Growth	Automation	Low-Cost Goals
EFG	5 2.5-4	* 5-10	150-200 250-300	5x30-m lengths; 15 h	5x5 cm 3x10 cm	Yes; Meniscus ht., edge position	5 cm/min 150 μm 10x10 cm 5 days
WEB	7 3-4	4.7 3.5-4	50 150	3-4-m lengths; 17 h	2 per operator	Yes; melt level, replenishment	25 cm ² /min 150 μm 6 per operator 3 days
SOC	15 4-5	10 5	100 200	50-cm lengths	None	None	350 cm ² /min 100 μm 10x2x12.5 cm 5 days
RTR	9 2.5-5	7.5 3.5	100 150-200	30-cm lengths	4x1.3 cm 2x5 cm	None	7.9 cm/min 100 μm 3x7.5 cm Semicon; Cassette

Figure 3. Comparison of "Fast" Sheet Growth Processes Based on the Current Status of Productivity Parameters

The asterisk (*) denotes the best current results.

	Impurity Sources	Impurity Segregation	Impurity Redistribution	Use of Low-Grade Silicon Feedstock
WEB	Crucible (SiO_2) Heat shields (Mo)	* $k_{\text{eff}} \approx 1 - 3 k_0$; $k_{\text{eff}} < 1$ with cont. replenishment	None	Grew from impure melt (Fe, Ti, V,...); expect most effect on growth
RTR	Microribbon feedstock (Mo)	Some zone refinement; $k_{\text{eff}} \gg 1$	Possible with interface shape control (w, t)	Unetched feedstock used; expect some effect on growth
EFG	Crucible (SiO_2 , C) Die (C) Cartridge	$k_{\text{eff}} = 1$	Controlled with die design; demonstrated	mg-silicon feedstock used; expect some effect on growth
SOC	Crucible (SiO_2) Mullite substrate	$k_{\text{eff}} = 1$ (?)	Possible with interface shape control (t)	No experience; expect least effect on growth

Figure 4. Comparison of "Fast" Sheet Growth Processes Based on the Effects of Impurities

The ranking is based on best ultimate potential. The asterisk (*) denotes best potential in a given area.

techniques is the presence of thermal-stress-related buckles at the higher rates of growth. The morphological features of the sheets are important, of course, in view of their intended use as solar cell substrates.

	Crystalline Structure	Control of Crystallinity	Sheet Morphology
WEB *	Single crystal Coplanar twins {111} surface <10 ⁴ /cm ² dislocations	Inherently good; Can grow with extra dendrite or poly	Smooth Some microsteps Buckles
EFG	Polycrystal Twins; Grain boundaries Central grains SiC particles ~10 ⁴ /cm ² dislocations	Possible with interface shape control (t); Environment control (Kalejs et al.) *	Striations Buckles SiC particles
RTR	Polycrystal Twins; Grain boundaries G.B. near edges Dendrites ~10 ⁵ /cm ² dislocations	Possible with interface shape control (t, w); Lateral control demonstrated	Dendrites Buckles
SOC	Polycrystal Twins; Grain boundaries SiC near substrate 10 ⁴ - 10 ⁵ /cm ² dislocations	Some possibility with interface shape control (t)	Mostly flat; Effects of slotted substrate

* From The Electrochemical Society 1980

Figure 5. Comparison of "Fast" Sheet Growth Processes Based on Considerations of Crystallinity

The ranking is based on the best ultimate potential of the techniques.

2.5 SOLAR CELL RESULTS

The final ranking of "fast" sheet growth processes is based on their current status as solar cell substrates. The two sets of values in the efficiency and area columns of Fig. 6 refer to the best results (top) and the typically achieved values (bottom). The highest solar cell efficiencies have been shown in WEB material. The best experience with large area solar cells has been achieved with sheets produced using the EFG technique. EFG also ranks highest in the experiences with solar cell modules. Other columns in Fig. 6 list the typical air-mass-one (AM 1) solar cell values, the efficiency goals for the various techniques, and some of the specific concerns in utilizing the sheet materials as solar cell substrates (e.g., handling- and fabrication-related problems). A major concern for all the techniques, with the possible exception of WEB, is the quality of the sheet material; high efficiency solar cells must be fabricated with a high yield in order to achieve the low-cost objectives.

	Efficiency (AM 1)	Area (cm ²)	Typical Cell Parameters			Module Results	Efficiency Goal (AM 1)	Concerns
			V _{oc} (mV)	J _{sc} (mA/cm ²)	FF			
WEB	15.5% *	1	565	31	0.75	0.1 m ² (1 ft ²); 11-12%	15%	Dendrites
	12-13%	11						
EFG	13-14%	10-50 *	560	29	0.72	0.4 m ² * (4 ft ²); 9-10%	12%	Sheet quality
	10-11%	50						
RTR	13%	2	590	26	0.74	None	14%	Rigid edge Sheet quality
	11-12%	4						
SOC	10.1%	4	560	24	0.74	None	11%	Back contact Sheet quality
	9%	4						

Figure 6. Comparison of "Fast" Sheet Growth Processes Based on the Current Status of Solar Cell Results

The asterisk (*) denotes the best current results.

SECTION 3.0

STATUS OF "FASTER" AND "FASTEST" RIBBON GROWTH TECHNIQUES

The attainment of very rapid silicon sheet production rates has been of interest to several researchers in recent years; the motivation is, of course, to further reduce the cost of silicon substrates for photovoltaic applications. This section reviews the status of the novel technologies which have evolved and examines some of the problems which remain to be resolved.

3.1 HORIZONTAL RIBBON GROWTH

The "faster" growth rate in horizontal ribbon growth (see Fig. 1) results from the large area of the solid-liquid interface and the very close proximity of the interface to the heat loss surface. This leads to the very effective removal of the latent heat of solidification. Although the linear growth rates are quite high in this technique (up to ~100 cm/min), the actual rate of growth of the crystal (i.e., rate of advance of the solid-liquid interface) is approximately the same as that obtained using conventional silicon ingot growth techniques. Thus, horizontal ribbon growth offers the potential to produce high quality, single-crystal sheet material.

The process of horizontal ribbon growth was originally envisioned (Bleil 1969) as the growth of a sheet from the top surface of a melt in a crucible. This technique for silicon sheet growth, however, has required a great deal of ingenuity in the design of the growth system (furnace and crucible). As far as the author is aware, two groups of researchers have been working in this area in recent years; their techniques are denoted as HRG and LASS in Fig. 7. The HRG process (Cullen and Surek 1980) has been under development for about four years and is at a more advanced stage than LASS, which has been under development for about a year (Jewett and Bates 1980). While HRG relies on active heating and cooling elements to control the growth, the emphasis in the LASS technique is on the design of passive thermal elements to stabilize the growth. Figure 7 shows some of the highlights in the development of these two techniques, as well as the values achieved for various growth and material parameters.

Several concerns need to be resolved before the potential of these techniques can be determined. The understanding of seeding and steady-state growth is generally inadequate. The processes involve relatively complex designs of the growth system, and they require very accurate controls of the temperature profiles and the melt level. The width and thickness uniformity of the ribbons is a concern. Wider and thinner ribbons need to be grown. The relative immaturity of these techniques is consistent, however, with the low levels of effort compared to the effort given to the "fast" sheet growth processes.

3.2 MELT QUENCHING OR SPINNING

Recent work on extremely rapid growth of silicon sheet has been reported by researchers at the Telecommunication Research Institute of Tohoku University (Tsuya et al. 1980). Termed "roller quenching" (see schematic in Fig. 1), the technique is based on existing commercial technologies for producing continuous ribbons of amorphous materials. Figure 8 summarizes the technique applied to silicon, the growth and material parameter results, and some of the major concerns. Note the simplicity of the technique (roller quenching in air), the extremely high growth rate (30 m/s), and the preliminary solar cell results. Extensive efforts will be required, however, to resolve the various problems.

	Technique Development	Width (mm)	Thickness (mm)	Length (cm)	Rate (cm/min)	Crystallinity	Electrical Properties
HRG*	Crucible/furnace design; Gas cooling; Inclined growth ($< 10^\circ$); Studies of seeding; Melt replenishment	50 (max)	0.2-0.35 (min)	> 500	41.5	Single ($10^5/\text{cm}^2$ dsl.)	Mobility, lifetime comparable to CZ; 9-10% (AM 1, no AR)
		10-30	0.4-2		85	Poly	
LASS**	Crucible/furnace design; Gas cooling; Leading edge/lateral stabilizers; Low angle growth ($\sim 4^\circ$); Melt level control	8-25	0.3-1	75	20-60	Poly No seeding $> 5\text{-mm}$ grains	Preliminary

* Horizontal Ribbon Growth (Japan Silicon Co.)

** Low Angle Silicon Sheet Growth (Energy Materials Corp.)

Figure 7. Status of "Faster" Sheet Growth Processes

Best (top), typical (bottom), and ranges of parameter values are indicated.

Technique: Based on existing technology for amorphous materials
Single or double roller quenching in air

Thickness, Width = f $\left(\begin{array}{ll} \text{roller material} & \text{Cu} \\ \text{roller diameter} & 40 \text{ cm} \\ \text{rotation speed} & 1000 \text{ rpm} \\ \text{ejection pressure} & 0.5 \text{ atm} \\ \text{melt temperature} & 1500^\circ \text{C} \\ \text{nozzle diameter} & 0.5 \text{ mm} \end{array} \right)$

Results: Thickness 20-200 μm
Width 1-10 mm with single roller
up to 50 mm with double roller
Rate 30 m/s
Grain Size 20-30 μm , columnar
Solar Cells 5-8%, AM1 with CVD epi-junction

Problems: Small grain size; width and thickness uniformity
Stress and impurity problems
Continuous growth
New technology; low level of effort

Source: Tsuya et al. 1980.

Figure 8. Status of Silicon Ribbon Growth by Roller Quenching

SECTION 4.0

SUMMARY

The development of silicon sheet growth processes has been truly remarkable over the past few years. A number of the techniques are nearly at the stage where their potential to meet the low-cost objectives for terrestrial photovoltaics can be fully demonstrated. This paper reviews and compares the so-called "fast" ribbon growth processes (EFG, WEB, SOC, and RTR), and identifies some of the problems that need to be resolved. Although there is good reason to expect that the objectives to achieve low-cost silicon photovoltaic systems will be met, it is not possible to choose, in the author's opinion, among the various sheet growth processes at this time. This is especially true if one considers the results of the more rapid sheet growth techniques also reviewed in this paper, or the results of other novel sheet growth approaches reported recently such as the edge-supported pulling process described by Ciszek (Electrochemical Society 1980).

SECTION 5.0**REFERENCES**

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